Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/905,137	YAMADA, EIICHI	
Examiner	Art Unit	
Xu Mei	2644	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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360	32		
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INT	INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
CHEEK 08/925,126	70/5	V2
Cara 00/725,126	17710	
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